# **Power MOSFET**

# 20 V, 890 mA, Single N–Channel with ESD Protection, SOT–723

#### Features

- N-Channel Switch with Low R<sub>DS(on)</sub>
- 44% Smaller Footprint and 38% Thinner than SC89
- Low Threshold Levels Allowing 1.5 V R<sub>DS(on)</sub> Rating
- Operated at Low Logic Level Gate Drive
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### Applications

- Load/Power Switching
- Interface Switching
- Logic Level Shift
- Battery Management for Ultra Small Portable Electronics

# **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Vol	V <sub>DSS</sub>	20	V		
Gate-to-Source Volt	age		V <sub>GS</sub>	±8	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	890	mA
Current (Note 1)	State	$T_A = 85^{\circ}C$		640	
	t ≤ 5 s	$T_A = 25^{\circ}C$		990	
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	P <sub>D</sub>	450	mW
	t ≤ 5 s			550	
Continuous Drain	Steady $T_A = 25^{\circ}C$		Ι <sub>D</sub>	750	mA
Current (Note 2)	State	T <sub>A</sub> = 85°C		540	
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	PD	310	mW
Pulsed Drain $t_p = 10 \ \mu s$ Current			I <sub>DM</sub>	1.8	A
Operating Junction a Temperature	T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C		
Lead Temperature fo (1/8" from case for 10		Purposes	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

 Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)

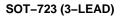
2. Surface mounted on FR4 board using the minimum recommended pad size

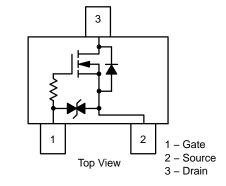


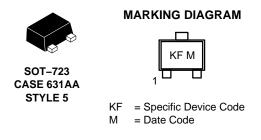
# **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> Max
20 V	0.20 Ω @ 4.5 V	890 mA
	0.26 Ω @ 2.5 V	790 mA
	0.43 Ω @ 1.8 V	700 mA
	0.56 Ω @ 1.5 V	200 mA







#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTK3134NT1G	SOT-723	4000 / Tape & Reel		
NTK3134NT5G	SOT-723	8000 / Tape & Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Мах	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	280	°C/W
Junction-to-Ambient $- t = 5 s$ (Note 3)	$R_{ hetaJA}$	228	
Junction-to-Ambient - Steady State Minimum Pad (Note 4)	$R_{ hetaJA}$	400	

Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)
Surface mounted on FR4 board using the minimum recommended pad size

#### **MOSFET ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain–to–Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		20			V
Drain–to–Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	$I_D = 250 \ \mu A$ , Reference to $25^{\circ}C$			18		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 16 \text{ V}$	$T_J = 25^{\circ}C$			1.0	μΑ
			T <sub>J</sub> = 125°C			2.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 4$	4.5 V			±0.5	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		0.45		1.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.4		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 890 \text{ mA}$			0.20	0.35	Ω
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 780 mA			0.26	0.45	
	Γ Γ	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 700 mA			0.43	0.65	
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 20	00 mA		0.56	1.2	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 800 mA			1.6		S
CHARGES, CAPACITANCES AND	GATE RESISTAN	CE				•	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 16 V			79	120	pF

Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 16 V	79	120	pF
Output Capacitance	C <sub>OSS</sub>		13	20	
Reverse Transfer Capacitance	C <sub>RSS</sub>		9.0	15	

#### SWITCHING CHARACTERISTICS, V<sub>GS</sub> = 4.5 V (Note 6)

Turn On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}, I_{D} = 500 \text{ mA},$	6.7	ns
Rise Time	t <sub>r</sub>	R <sub>G</sub> = 10 Ω	4.8	
TurnOff Delay Time	t <sub>d(OFF)</sub>		17.3	
Fall Time	t <sub>f</sub>		7.4	

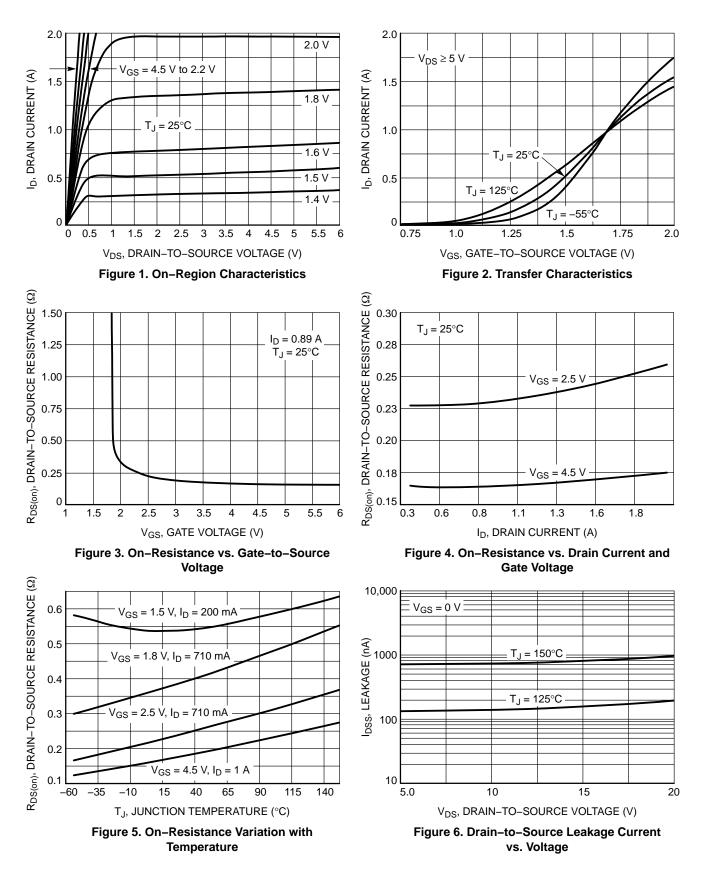
#### DRAIN SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 350 \text{ mA}$	T <sub>J</sub> = 25°C	0.75	1.2	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 V, d_{ISD}/d_t = 100 A/\mu s,$ $I_S = 1.0 A, V_{DD} = 20 V$		8.1		ns
Charge Time	ta	$I_{\rm S} = 1.0  {\rm A},  {\rm V}_{\rm DD} = 2$	:0 V	6.4		
Discharge Time	t <sub>b</sub>	]		1.7		
Reverse Recovery Charge	Q <sub>RR</sub>	]		3.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width =  $300 \ \mu$ s, duty cycle = 2%

6. Switching characteristics are independent of operating junction temperatures

#### **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**

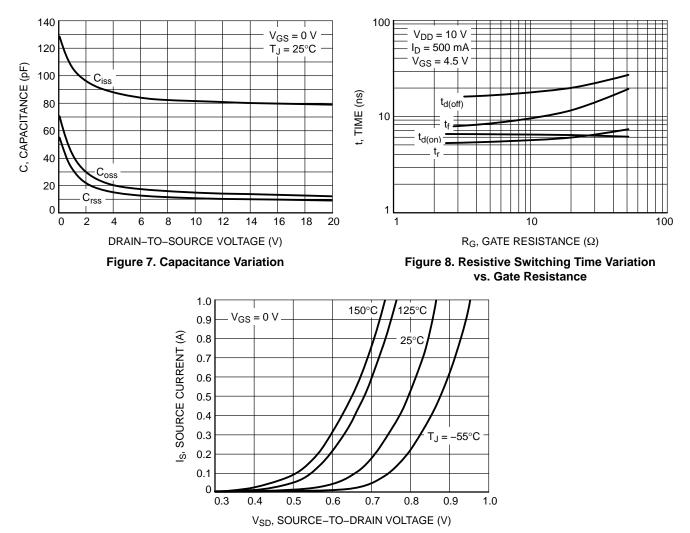
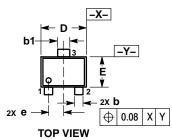
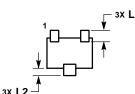


Figure 9. Diode Forward Voltage vs. Current

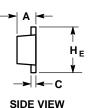
#### PACKAGE DIMENSIONS

SOT-723 CASE 631AA ISSUE D





**BOTTOM VIEW** 



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL. 2 3

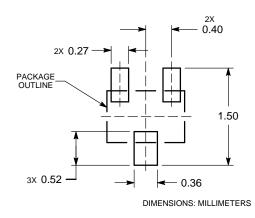
4

DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.45	0.50	0.55			
b	0.15	0.21	0.27			
b1	0.25	0.31	0.37			
С	0.07	0.12	0.17			
D	1.15	1.20	1.25			
Е	0.75	0.80	0.85			
е		0.40 BSC	)			
ΗE	1.15	1.20	1.25			
L	0.29 REF					
L2	0.15	0.20	0.25			

STYLE 5: PIN 1. GATE 2. SOURCE 3. DRAIN

RECOMMENDED SOLDERING FOOTPRINT\*



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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